Am27S31/27S31A

(512x8) Bipolar PROM



DISTINCTIVE CHARACTERISTICS

- High speed --- 35 ns max commercial range access time
- Excellent performance over full military and commercial ranges
- Highly reliable, ultra-fast programming Platinum-Silicide fuese
- · High programming yield
- Low current PNP inputs
- · High current and three-state outputs
- Fast chip select

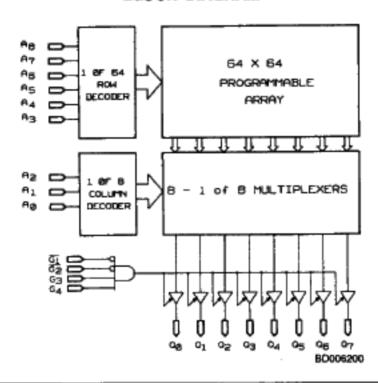
GENERAL DESCRIPTION

The Am27S31 (512 words by 8 bits) is a Schottky TTL Programmable Read-Only Memory (PROM).

This device is available in three-state output version compatible with low-power Schottky bus standards capable

of satisfying the requirements of a variety of microprogrammable controls, mapping functions, code conversion, or logic replacement. Easy word-depth expansion is facilitated by both active LOW (\overline{G}_1 and \overline{G}_2) and active HIGH (G_3 and G_4) output enables.

BLOCK DIAGRAM



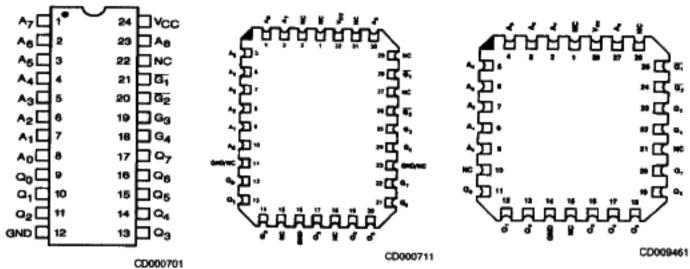
PRODUCT SELECTOR GUIDE

Part Number	Am2	7531A	Am27S31			
Address Access Time	35 ns	45 ns	55 ns	70 ns		
Operating Range	С	м	С	М		

Publication # Rev. Amendment 03207 D /0 Issue Date: Jenuary 1989

CONNECTION DIAGRAMS Top View

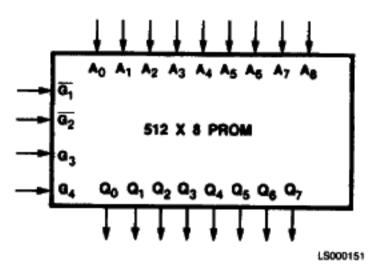
DIPs* LCCs**



- "Also available in a 24-Pin Flatpack. Pinout identical to DIPs.
- "*Also available in a 28-Pin Square PLCC. Pinout identical to LCC.

Note: Pin 1 is marked for orientation.

LOGIC SYMBOL



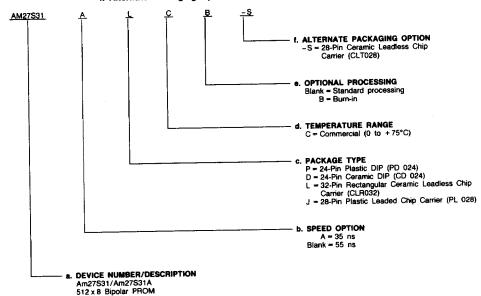
V_{CC}/ = Power Supply GND/ = Ground

ORDERING INFORMATION

Standard Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of: a. Device Number

- b. Speed Option (if applicable)
- c. Package Type
- d. Temperature Range
- e. Optional Processing
- f. Alternate Packaging Option



Valid Combinations									
AM27S31	PC, PCB, DC, DCB, LC, LC-S, LCB, LCB-S,								
AM27S31A	JC, JCB								

Valid Combinations

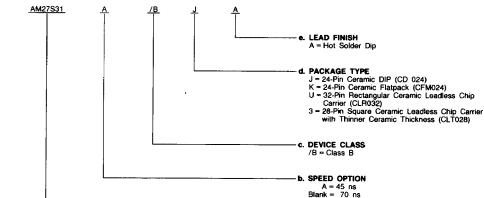
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, to check on newly released valid combinations, and to obtain additional data on AMD's standard military grade products.

MILITARY ORDERING INFORMATION

APL Products

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883C requirements. The order number (Valid Combination) for APL products is formed by a combination of: a. Device Number

- b. Speed Option (if applicable)
- c. Device Class
- d. Package Type e. Lead Finish



Valid Combinations AM27S31 /BJA, /BKA, AM27S31A /BUA, /B3A

a. DEVICE NUMBER/DESCRIPTION Am27S31/Am27S31A 512 x 8 Bipolar PROM

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations or to check for newly released valid combinations.

Group A Tests

Group A tests consist of Subgroups 1, 2, 3, 7, 8, 9, 10, 11.

MILITARY BURN-IN

Military burn-in is in accordance with the current revision of MIL-STD-883, Test Method 1015, Conditions A through E. Test conditions are selected at AMD's option.

PIN DESCRIPTION

A₀ - A₈ Address Inputs

The 9-bit field presented at the address inputs selects one of 512 memory locations to be read from.

Q₀ - Q₇ Data Output Port

The Outputs whose state represents the data read from the selected memory locations.

G₁, G₂, G₃, G₄ Output Enable

Provides direct control of the Q-output buffers. Outputs disabled forces all three-state outputs to a floating or high-impedance state.

Enable =
$$\overline{G_1} \cdot \overline{G_2} \cdot G_3 \cdot G_4$$

Disable =
$$\overline{G_1 \cdot G_2 \cdot G_3 \cdot G_4}$$

= $G_1 + G_2 + \overline{G_3} + \overline{G_4}$

V_{CC} Device Power Supply Pin

The most positive of the logic power supply pins.

GND Device Power Supply Pin

The most negative of the logic power supply pins.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature65 to +150°C Ambient Temperature with
Power Applied55 to +125°C
Supply Voltage0.5 V to +7.0 V
DC Voltage Applied to Outputs
(Except During Programming)0.5 V to +VCC Max.
DC Voltage Applied to Outputs
During Programming21 V
Output Current into Outputs During
Programming (Max Duration of 1 sec)
DC input Voltage0.5 V to +5.5 V
DC Input Current30 mA to +5 mA

Stresses above those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices Ambient Temperature Supply Voltage (V _{CC})	(T _A) 0 to +75°C+4.75 V to +5.25 V
Military (M) Devices*	
Case Temperature (To	c) –55 to +125°C
Supply Voltage (VCC)	+4.5 V to +5.5 V

Operating ranges define those limits between which the functionality of the device is guaranteed.

*Military Product 100% tested at $T_C = +25$ °C, +125°C, and -55°C.

DC CHARACTERISTICS over operating ranges unless otherwise specified (for APL Products, Group A, Subgroups 1, 2, 3 are tested unless otherwise noted)

Parameter Symbol	Parameter Description		Test Condition	Min.	Тур.	Max.	Unit	
V _{OH} (Note 1)	Output HIGH Voltage	V _{CC} = Min., I _{OI} V _{IN} = V _{IH} or V	2.4			٧		
VOL.	Output LOW Voltage	V _{CC} = Min., I _O V _{IN} = V _{IH} or V			0.50	٧		
ViH	Input HIGH Level	Guaranteed ing voltage for all	2.0			٧		
ViL	Input LOW Level	Guaranteed ing			0.8	٧		
ηL	Input LOW Current	V _{CC} = Max., V			-0.250	mA		
lян	Input HIGH Current	V _{CC} = Max., V			25	μΑ		
I _{SC} (Note 1)	Output Short-Circuit Current	V _{CC} = Max., V	-20		-90	mA		
lcc	Power Supply Current	All inputs = GND V _{CC} = Max.					175	mA
VI	Input Clamp Voltage	V _{CC} = Min., 1 _{IN} = -18 mA					-1.2	٧
<u>''</u>				Vo = Voc			40	
CEX	Output Leakage Current	V _{CC} = Max.		Vo = 2.4 V		40		μA
CEX		VG = 2.4 V (Note 1) V _O = 0.4 V					-40	
CiN	Input Capacitance	V _{IN} = 2.0 V @ V _{CC} = 5 V, T _A		4		pF		
Cout	Output Capacitance	V _{OUT} = 2.0 V V _{CC} = 5 V, T _A		8				

Notes: 1. This applies to three-state devices only.

2. V_{IL} and V_{IH} are input conditions of output tests and are not themselves directly tested. V_{IL} and V_{IH} are absolute voltages with respect to device ground and include all overshoots due to system and/or tester noise. Do not attempt to test these values without suitable equipment.

3. Not more than one output should be shorted at a time. Duration of the short circuit should not be more than one second.

4. These parameters are not 100% tested, but are evaluated at initial characterization and at any time the design is modified where capacitance

SWITCHING CHARACTERISTICS over operating ranges unless otherwise specified (for APL Products, Group A, Subgroups 9, 10, 11 are tested unless otherwise noted*)

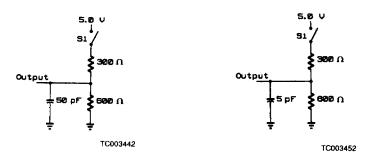
			Am27S31A				Am27S31				1
		COM'L		MIL		COM'L		MIL			
		Parameter Description	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit
1	TAVQV	Address Valid to Output Valid Access Time		35		45		55		70	ns
2	TGVQZ	Delay from Output Enable Valid to Output Hi-Z		20		25		25		30	ns
3	TGVQV	Delay from Output Enable Valid to Output Valid		20		25		25		30	ns

See also Switching Test Circuits.

- Notes: 1. Tests are performed with input transition time of 5 ns or less, timing reference levels of 1.5 V, and input pulse levels of 0 to 3.0 V
 - using test load in A under Switching Test Circuits.

 2. TGVQZ is measured at steady state HIGH output voltage -0.5 V and steady state LOW output voltage +0.5 V ouput levels using the test load in B under Switching Test Circuits.
 - *Subgroups 7 and 8 apply to functional tests.

SWITCHING TEST CIRCUITS

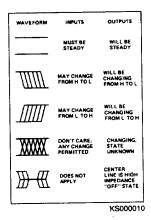


A. Output Load for all A-C tests except TGVQZ

B. Output Load for TGVQZ

- Notes: 1. All device test loads should be located within 2" of device output pin.
 - 2. S₁ is open for Output Data HIGH to Hi-Z and Hi-Z to Output Data HIGH tests.
 - S₁ is closed for all other AC tests.
 - 3. Load capacitance includes all stray and fixture capacitance.

SWITCHING WAVEFORMS KEY TO SWITCHING WAVEFORMS



ADDRESS
Ag - Ag
OUTPUTS
Qg - Q7
WF021260